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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	e200z0h
Core Size	32-Bit Single-Core
Speed	64MHz
Connectivity	CANbus, FlexRay, LINbus, SPI, UART/USART
Peripherals	DMA, POR, PWM, WDT
Number of I/O	68
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	64K x 8
RAM Size	40K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 30x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/spc5604pef1mll6r

For high priority interrupt requests, the time from the assertion of the interrupt request from the peripheral to when the processor is executing the interrupt service routine (ISR) has been minimized. The INTC provides a unique vector for each interrupt request source for quick determination of which ISR has to be executed. It also provides a wide number of priorities so that lower priority ISRs do not delay the execution of higher priority ISRs. To allow the appropriate priorities for each source of interrupt request, the priority of each interrupt request is software configurable.

When multiple tasks share a resource, coherent accesses to that resource need to be supported. The INTC supports the priority ceiling protocol (PCP) for coherent accesses. By providing a modifiable priority mask, the priority can be raised temporarily so that all tasks which share the same resource can not preempt each other.

The INTC provides the following features:

- Unique 9-bit vector for each separate interrupt source
- 8 software triggerable interrupt sources
- 16 priority levels with fixed hardware arbitration within priority levels for each interrupt source
- Ability to modify the ISR or task priority: modifying the priority can be used to implement the Priority Ceiling Protocol for accessing shared resources.
- 2 external high priority interrupts directly accessing the main core and I/O processor (IOP) critical interrupt mechanism

1.5.7 System status and configuration module (SSCM)

The system status and configuration module (SSCM) provides central device functionality.

The SSCM includes these features:

- System configuration and status
  - Memory sizes/status
  - Device mode and security status
  - Determine boot vector
  - Search code flash for bootable sector
  - DMA status
- Debug status port enable and selection
- Bus and peripheral abort enable/disable

1.5.8 System clocks and clock generation

The following list summarizes the system clock and clock generation on the MPC5604P:

- Lock detect circuitry continuously monitors lock status
- Loss of clock (LOC) detection for PLL outputs
- Programmable output clock divider (÷1, ÷2, ÷4, ÷8)
- FlexPWM module and eTimer module can run on an independent clock source
- On-chip oscillator with automatic level control
- Internal 16 MHz RC oscillator for rapid start-up and safe mode: supports frequency trimming by user application

1.5.9 Frequency-modulated phase-locked loop (FMPLL)

The FMPLL allows the user to generate high speed system clocks from a 4–40 MHz input clock. Further, the FMPLL supports programmable frequency modulation of the system clock. The PLL multiplication factor, output clock divider ratio are all software configurable.

The PLL has the following major features:

- Input clock frequency: 4–40 MHz

- 32 message buffers of up to 8-bytes data length
- Each message buffer configurable as Rx or Tx, all supporting standard and extended messages
- Programmable loop-back mode supporting self-test operation
- 3 programmable mask registers
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Independent of the transmission medium (an external transceiver is assumed)
- High immunity to EMI
- Short latency time due to an arbitration scheme for high-priority messages
- Transmit features
  - Supports configuration of multiple mailboxes to form message queues of scalable depth
  - Arbitration scheme according to message ID or message buffer number
  - Internal arbitration to guarantee no inner or outer priority inversion
  - Transmit abort procedure and notification
- Receive features
  - Individual programmable filters for each mailbox
  - 8 mailboxes configurable as a six-entry receive FIFO
  - 8 programmable acceptance filters for receive FIFO
- Programmable clock source
  - System clock
  - Direct oscillator clock to avoid PLL jitter

1.5.21 Safety port (FlexCAN)

The MPC5604P MCU has a second CAN controller synthesized to run at high bit rates to be used as a safety port. The CAN module of the safety port provides the following features:

- Identical to the FlexCAN module
- Bit rate as fast as 7.5 Mbit/s at 60 MHz CPU clock using direct connection between CAN modules (no physical transceiver required)
- 32 message buffers of up to 8 bytes data length
- Can be used as a second independent CAN module

1.5.22 FlexRay

The FlexRay module provides the following features:

- Full implementation of FlexRay Protocol Specification 2.1
- 32 configurable message buffers can be handled
- Dual channel or single channel mode of operation, each as fast as 10 Mbit/s data rate
- Message buffers configurable as Tx, Rx or RxFIFO
- Message buffer size configurable
- Message filtering for all message buffers based on FrameID, cycle count and message ID
- Programmable acceptance filters for RxFIFO message buffers

Table 5. Pin muxing

Port pin	Pad configuration register (PCR)	Alternate function[1,2]	Functions	Peripheral[3]	I/O direction[4]	Pad speed[5]		Pin No.	
						SRC = 0	SRC = 1	100-pin	144-pin
Port A (16-bit)									
A[0]	PCR[0]	ALT0 ALT1 ALT2 ALT3 —	GPIO[0] ETC[0] SCK F[0] EIRQ[0]	SIUL eTimer_0 DSPI_2 FCU_0 SIUL	I/O I/O O O I	Slow	Medium	51	73
A[1]	PCR[1]	ALT0 ALT1 ALT2 ALT3 —	GPIO[1] ETC[1] SOUT F[1] EIRQ[1]	SIUL eTimer_0 DSPI_2 FCU_0 SIUL	I/O I/O O O I	Slow	Medium	52	74
A[2][6]	PCR[2]	ALT0 ALT1 ALT2 ALT3 — — —	GPIO[2] ETC[2] — A[3] SIN ABS[0] EIRQ[2]	SIUL eTimer_0 — FlexPWM_0 DSPI_2 MC_RGM SIUL	I/O I/O — O I I I	Slow	Medium	57	84
A[3][6]	PCR[3]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[3] ETC[3] CS0 B[3] ABS[2] EIRQ[3]	SIUL eTimer_0 DSPI_2 FlexPWM_0 MC_RGM SIUL	I/O I/O I/O O I I	Slow	Medium	64	92
A[4][6]	PCR[4]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[4] ETC[0] CS1 ETC[4] FAB EIRQ[4]	SIUL eTimer_1 DSPI_2 eTimer_0 MC_RGM SIUL	I/O I/O O I/O I I	Slow	Medium	75	108
A[5]	PCR[5]	ALT0 ALT1 ALT2 ALT3 —	GPIO[5] CS0 ETC[5] CS7 EIRQ[5]	SIUL DSPI_1 eTimer_1 DSPI_0 SIUL	I/O I/O I/O O I	Slow	Medium	8	14
A[6]	PCR[6]	ALT0 ALT1 ALT2 ALT3 —	GPIO[6] SCK — — EIRQ[6]	SIUL DSPI_1 — — SIUL	I/O I/O — — I	Slow	Medium	2	2
A[7]	PCR[7]	ALT0 ALT1 ALT2 ALT3 —	GPIO[7] SOUT — — EIRQ[7]	SIUL DSPI_1 — — SIUL	I/O O — — I	Slow	Medium	4	10

Table 5. Pin muxing (continued)

Port pin	Pad configuration register (PCR)	Alternate function[1,2]	Functions	Peripheral[3]	I/O direction[4]	Pad speed[5]		Pin No.	
						SRC = 0	SRC = 1	100-pin	144-pin
B[10]	PCR[26]	ALT0 ALT1 ALT2 ALT3 —	GPIO[26] — — — AN[12]	SIUL — — — ADC_0 / ADC_1	Input only	—	—	36	53
B[11]	PCR[27]	ALT0 ALT1 ALT2 ALT3 —	GPIO[27] — — — AN[13]	SIUL — — — ADC_0 / ADC_1	Input only	—	—	37	54
B[12]	PCR[28]	ALT0 ALT1 ALT2 ALT3 —	GPIO[28] — — — AN[14]	SIUL — — — ADC_0 / ADC_1	Input only	—	—	38	55
B[13]	PCR[29]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[29] — — — AN[0] RXD	SIUL — — — ADC_1 LIN_1	Input only	—	—	42	60
B[14]	PCR[30]	ALT0 ALT1 ALT2 ALT3 — — —	GPIO[30] — — — AN[1] ETC[4] EIRQ[19]	SIUL — — — ADC_1 eTimer_0 SIUL	Input only	—	—	44	64
B[15]	PCR[31]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[31] — — — AN[2] EIRQ[20]	SIUL — — — ADC_1 SIUL	Input only	—	—	43	62
Port C (16-bit)									
C[0]	PCR[32]	ALT0 ALT1 ALT2 ALT3 —	GPIO[32] — — — AN[3]	SIUL — — — ADC_1	Input only	—	—	45	66
C[1]	PCR[33]	ALT0 ALT1 ALT2 ALT3 —	GPIO[33] — — — AN[2]	SIUL — — — ADC_0	Input only	—	—	28	41

Table 5. Pin muxing (continued)

Port pin	Pad configuration register (PCR)	Alternate function[1,2]	Functions	Peripheral[3]	I/O direction[4]	Pad speed[5]		Pin No.	
						SRC = 0	SRC = 1	100-pin	144-pin
C[11]	PCR[43]	ALT0 ALT1 ALT2 ALT3	GPIO[43] ETC[4] CS2 CS0	SIUL eTimer_0 DSPI_2 DSPI_3	I/O I/O O I/O	Slow	Medium	55	80
C[12]	PCR[44]	ALT0 ALT1 ALT2 ALT3	GPIO[44] ETC[5] CS3 CS1	SIUL eTimer_0 DSPI_2 DSPI_3	I/O I/O O O	Slow	Medium	56	82
C[13]	PCR[45]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[45] ETC[1] — — EXT_IN EXT_SYNC	SIUL eTimer_1 — — CTU_0 FlexPWM_0	I/O I/O — — I I	Slow	Medium	71	101
C[14]	PCR[46]	ALT0 ALT1 ALT2 ALT3	GPIO[46] ETC[2] EXT_TGR —	SIUL eTimer_1 CTU_0 —	I/O I/O O —	Slow	Medium	72	103
C[15]	PCR[47]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[47] CA_TR_EN ETC[0] A[1] EXT_IN EXT_SYNC	SIUL FlexRay_0 eTimer_1 FlexPWM_0 CTU_0 FlexPWM_0	I/O O I/O O I I	Slow	Symmetric	85	124
Port D (16-bit)									
D[0]	PCR[48]	ALT0 ALT1 ALT2 ALT3	GPIO[48] CA_TX ETC[1] B[1]	SIUL FlexRay_0 eTimer_1 FlexPWM_0	I/O O I/O O	Slow	Symmetric	86	125
D[1]	PCR[49]	ALT0 ALT1 ALT2 ALT3 —	GPIO[49] — ETC[2] EXT_TRG CA_RX	SIUL — eTimer_1 CTU_0 FlexRay_0	I/O — I/O O I	Slow	Medium	3	3
D[2]	PCR[50]	ALT0 ALT1 ALT2 ALT3 —	GPIO[50] — ETC[3] X[3] CB_RX	SIUL — eTimer_1 FlexPWM_0 FlexRay_0	I/O — I/O I/O I	Slow	Medium	97	140
D[3]	PCR[51]	ALT0 ALT1 ALT2 ALT3	GPIO[51] CB_TX ETC[4] A[3]	SIUL FlexRay_0 eTimer_1 FlexPWM_0	I/O O I/O O	Slow	Symmetric	89	128

Table 5. Pin muxing (continued)

Port pin	Pad configuration register (PCR)	Alternate function[1,2]	Functions	Peripheral[3]	I/O direction[4]	Pad speed[5]		Pin No.	
						SRC = 0	SRC = 1	100-pin	144-pin
G[3]	PCR[99]	ALT0 ALT1 ALT2 ALT3	GPIO[99] A[2] — —	SIUL FlexPWM_0 — —	I/O O — —	Slow	Medium	—	104
G[4]	PCR[100]	ALT0 ALT1 ALT2 ALT3	GPIO[100] B[2] — —	SIUL FlexPWM_0 — —	I/O O — —	Slow	Medium	—	100
G[5]	PCR[101]	ALT0 ALT1 ALT2 ALT3	GPIO[101] X[3] — —	SIUL FlexPWM_0 — —	I/O I/O — —	Slow	Medium	—	85
G[6]	PCR[102]	ALT0 ALT1 ALT2 ALT3	GPIO[102] A[3] — —	SIUL FlexPWM_0 — —	I/O O — —	Slow	Medium	—	98
G[7]	PCR[103]	ALT0 ALT1 ALT2 ALT3	GPIO[103] B[3] — —	SIUL FlexPWM_0 — —	I/O O — —	Slow	Medium	—	83
G[8]	PCR[104]	ALT0 ALT1 ALT2 ALT3 —	GPIO[104] — — — FAULT[0]	SIUL — — — FlexPWM_0	I/O — — — I	Slow	Medium	—	81
G[9]	PCR[105]	ALT0 ALT1 ALT2 ALT3 —	GPIO[105] — — — FAULT[1]	SIUL — — — FlexPWM_0	I/O — — — I	Slow	Medium	—	79
G[10]	PCR[106]	ALT0 ALT1 ALT2 ALT3 —	GPIO[106] — — — FAULT[2]	SIUL — — — FlexPWM_0	I/O — — — I	Slow	Medium	—	77
G[11]	PCR[107]	ALT0 ALT1 ALT2 ALT3 —	GPIO[107] — — — FAULT[3]	SIUL — — — FlexPWM_0	I/O — — — I	Slow	Medium	—	75

[1] ALT0 is the primary (default) function for each port after reset.

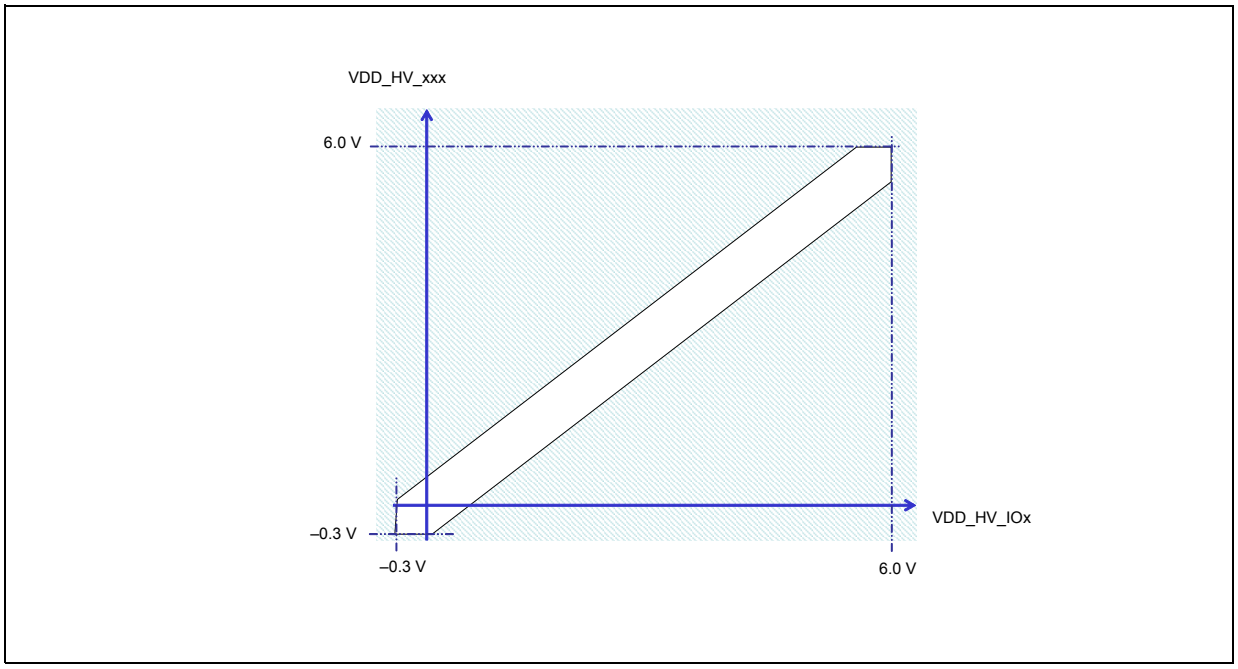


Figure 4. Power supplies constraints (–0.3 V ≤ $V_{DD\_HV\_IOx}$ ≤ 6.0 V)

The MPC5604P supply architecture allows of having ADC supply managed independently from standard V_{DD_HV} supply. Figure 5 shows the constraints of the ADC power supply.

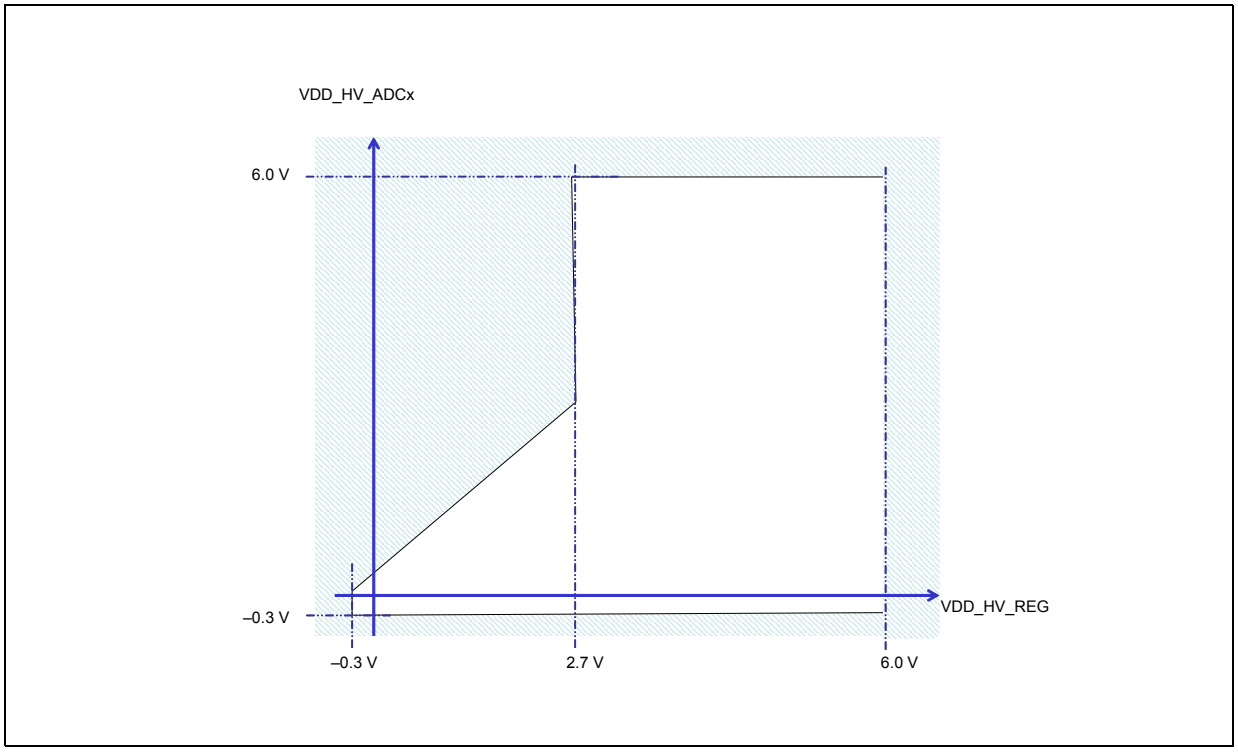


Figure 5. Independent ADC supply (–0.3 V ≤ $V_{DD\_HV\_REG}$ ≤ 6.0 V)

[4] To be connected to emitter of external NPN. Low voltage supplies are not under user control—they are produced by an on-chip voltage regulator—but for the device to function properly the low voltage grounds ($V_{SS\_LV\_xxx}$) must be shorted to high voltage grounds ($V_{SS\_HV\_xxx}$) and the low voltage supply pins ($V_{DD\_LV\_xxx}$) must be connected to the external ballast emitter.

[5] The low voltage supplies ($V_{DD\_LV\_xxx}$) are not all independent.

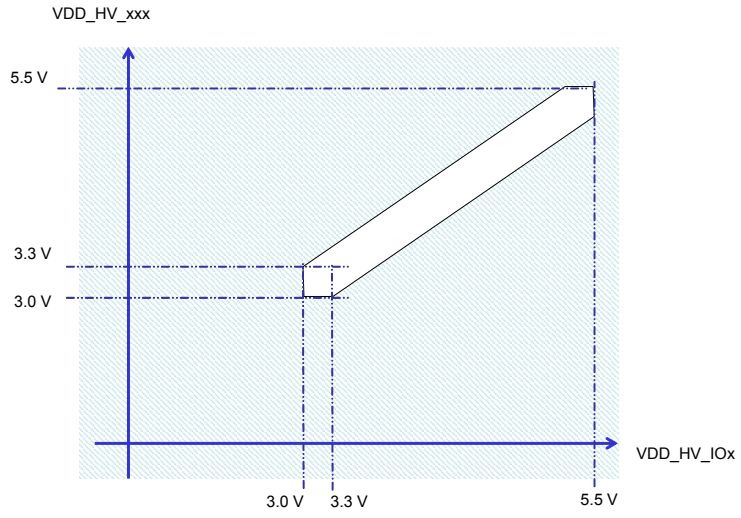
$V_{DD\_LV\_COR1}$ and $V_{DD\_LV\_COR2}$ are shorted internally via double bonding connections with lines that provide the low voltage supply to the data flash module. Similarly, $V_{SS\_LV\_COR1}$ and $V_{SS\_LV\_COR2}$ are internally shorted.

$V_{DD\_LV\_REGCOR}$ and $V_{DD\_LV\_REGCORx}$ are physically shorted internally, as are $V_{SS\_LV\_REGCOR}$ and $V_{SS\_LV\_CORx}$.

Table 9. Recommended operating conditions (3.3 V)

Symbol		Parameter	Conditions	Value		Unit
				Min	Max[1]	
V_{SS}	SR	Device ground	—	0	0	V
$V_{DD\_HV\_IOx}$[2]	SR	3.3 V input/output supply voltage	—	3.0	3.6	V
$V_{SS\_HV\_IOx}$	SR	Input/output ground voltage	—	0	0	V
$V_{DD\_HV\_FL}$	SR	3.3 V code and data flash supply voltage	—	3.0	3.6	V
			Relative to $V_{DD\_HV\_IOx}$	$V_{DD\_HV\_IOx}$ – 0.1	$V_{DD\_HV\_IOx}$ + 0.1	
$V_{SS\_HV\_FL}$	SR	Code and data flash ground	—	0	0	V
$V_{DD\_HV\_OSC}$	SR	3.3 V crystal oscillator amplifier supply voltage	—	3.0	3.6	V
			Relative to $V_{DD\_HV\_IOx}$	$V_{DD\_HV\_IOx}$ – 0.1	$V_{DD\_HV\_IOx}$ + 0.1	
$V_{SS\_HV\_OSC}$	SR	3.3 V crystal oscillator amplifier reference voltage	—	0	0	V
$V_{DD\_HV\_REG}$	SR	3.3 V voltage regulator supply voltage	—	3.0	3.6	V
			Relative to $V_{DD\_HV\_IOx}$	$V_{DD\_HV\_IOx}$ – 0.1	$V_{DD\_HV\_IOx}$ + 0.1	
$V_{DD\_HV\_ADC0}$[3]	SR	3.3 V ADC_0 supply and high reference voltage	—	3.0	5.5	V
			Relative to $V_{DD\_HV\_REG}$	$V_{DD\_HV\_REG}$ – 0.1	5.5	
$V_{SS\_HV\_ADC0}$	SR	ADC_0 ground and low reference voltage	—	0	0	V
$V_{DD\_HV\_ADC1}$[3]	SR	3.3 V ADC_1 supply and high reference voltage	—	3.0	5.5	V
			Relative to $V_{DD\_HV\_REG}$	$V_{DD\_HV\_REG}$ – 0.1	5.5	
$V_{SS\_HV\_ADC1}$	SR	ADC_1 ground and low reference voltage	—	0	0	V
$V_{DD\_LV\_REGCOR}$[4,5]	CC	Internal supply voltage	—	—	—	V

Figure 6 shows the constraints of the different power supplies.



Note: IO AC and DC characteristics are guaranteed only in the range of 3.0–3.6 V when PAD3V5V is low, and in the range of 4.5–5.5 V when PAD3V5V is high.

Figure 6. Power supplies constraints (3.0 V ≤ $V_{DD\_HV\_IOx}$ ≤ 5.5 V)

The MPC5604P supply architecture allows the ADC supply to be managed independently from the standard V_{DD_HV} supply. Figure 7 shows the constraints of the ADC power supply.

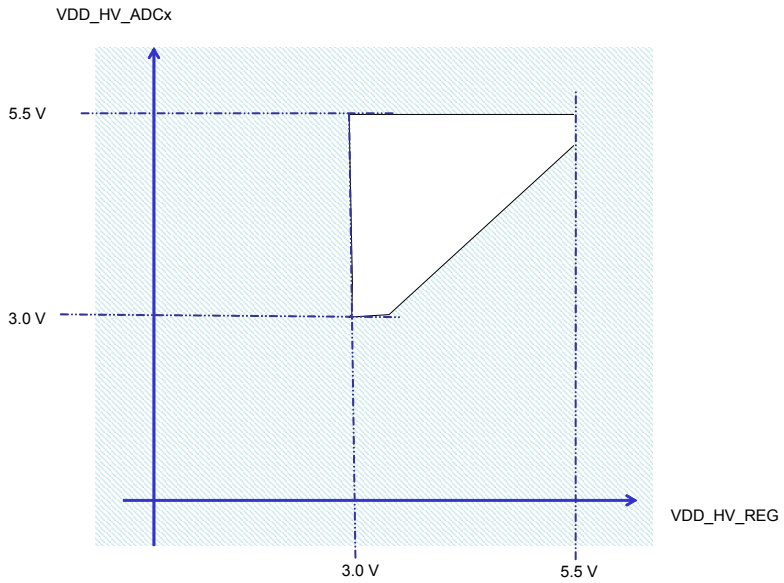


Figure 7. Independent ADC supply (3.0 V ≤ $V_{DD\_HV\_REG}$ ≤ 5.5 V)

Table 19. DC electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0) (continued)

Symbol	C	Parameter	Conditions	Value		Unit
				Min	Max	
I_{PD}	P	Equivalent pull-down current	$V_{IN} = V_{IL}$	10	—	µA
			$V_{IN} = V_{IH}$	—	130	
I_{IL}	P	Input leakage current (all bidirectional ports)	T_A = –40 to 125 °C	–1	1	µA
I_{IL}	P	Input leakage current (all ADC input-only ports)	T_A = –40 to 125 °C	–0.5	0.5	µA
C_{IN}	D	Input capacitance	—	—	10	pF
I_{PU}	D	$\overline{\text{RESET}}$, equivalent pull-up current	$V_{IN} = V_{IL}$	–130	—	µA
			$V_{IN} = V_{IH}$	—	–10	

1 "SR" parameter values must not exceed the absolute maximum ratings shown in Table 7.

Table 20. Supply current (5.0 V, NVUSRO[PAD3V5V] = 0)

Symbol	C		Parameter	Conditions		Value		Unit
						Typ	Max	
$I_{DD\_LV\_CORx}$	T	Supply current	RUN—Maximum mode[1]	$V_{DD\_LV\_CORx}$ externally forced at 1.3 V	40 MHz	62	77	mA
					64 MHz	71	88	
			RUN—Typical mode[2]		40 MHz	45	56	
					64 MHz	52	65	
	P		RUN—Maximum mode[3]	$V_{DD\_LV\_CORx}$ externally forced at 1.3 V	64 MHz	60	75	
			HALT mode[4]	$V_{DD\_LV\_CORx}$ externally forced at 1.3 V	—	1.5	10	
			STOP mode[5]	$V_{DD\_LV\_CORx}$ externally forced at 1.3 V	—	1	10	
I_{DD_FLASH}	T		Flash during read	$V_{DD\_HV\_FL}$ at 5.0 V	—	10	12	
			Flash during erase operation on 1 flash module	$V_{DD\_HV\_FL}$ at 5.0 V	—	15	19	
I_{DD_ADC}	T		ADC—Maximum mode[1]	$V_{DD\_HV\_ADC0}$ at 5.0 V $V_{DD\_HV\_ADC1}$ at 5.0 V f_{ADC} = 16 MHz	ADC_1	3.5	5	
					ADC_0	3	4	
			ADC—Typical mode[2]		ADC_1	0.8	1	
					ADC_0	0.005	0.006	
I_{DD_OSC}	T		Oscillator	V_{DD_OSC} at 5.0 V	8 MHz	2.6	3.2	

1 Maximum mode: FlexPWM, ADCs, CTU, DSPI, LINFlex, FlexCAN, 15 output pins, 1st and 2nd PLL enabled. I/O supply current excluded.

2 Typical mode configurations: DSPI, LINFlex, FlexCAN, 15 output pins, 1st PLL only. I/O supply current excluded.

Table 24. I/O weight (continued)

Pad	144 LQFP		100 LQFP	
	Weight 5V	Weight 3.3V	Weight 5V	Weight 3.3V
PAD[13]	10%	9%	12%	11%
PAD[82]	10%	9%	—	—
PAD[22]	10%	9%	13%	12%
PAD[83]	10%	9%	—	—
PAD[50]	10%	9%	14%	12%
PAD[97]	10%	9%	—	—
PAD[38]	10%	9%	14%	13%
PAD[14]	9%	8%	14%	13%
PAD[15]	9%	8%	15%	13%

Table 25. I/O consumption

Symbol		C	Parameter	Conditions[1]		Value			Unit
						Min	Typ	Max	
I_{SWTSLW}[2]	CC	D	Dynamic I/O current for SLOW configuration	C_L = 25 pF	V_{DD} = 5.0 V ± 10%, PAD3V5V = 0	—	—	20	mA
					V_{DD} = 3.3 V ± 10%, PAD3V5V = 1	—	—	16	
I_{SWTMED}(2)	CC	D	Dynamic I/O current for MEDIUM configuration	C_L = 25 pF	V_{DD} = 5.0 V ± 10%, PAD3V5V = 0	—	—	29	mA
					V_{DD} = 3.3 V ± 10%, PAD3V5V = 1	—	—	17	
I_{SWTFST}(2)	CC	D	Dynamic I/O current for FAST configuration	C_L = 25 pF	V_{DD} = 5.0 V ± 10%, PAD3V5V = 0	—	—	110	mA
					V_{DD} = 3.3 V ± 10%, PAD3V5V = 1	—	—	50	
I_{RMSSLW}	CC	D	Root medium square I/O current for SLOW configuration	C_L = 25 pF, 2 MHz	V_{DD} = 5.0 V ± 10%, PAD3V5V = 0	—	—	2.3	mA
				C_L = 25 pF, 4 MHz		—	—	3.2	
				C_L = 100 pF, 2 MHz		—	—	6.6	
				C_L = 25 pF, 2 MHz	V_{DD} = 3.3 V ± 10%, PAD3V5V = 1	—	—	1.6	
				C_L = 25 pF, 4 MHz		—	—	2.3	
				C_L = 100 pF, 2 MHz		—	—	4.7	

Table 27. Main oscillator output electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1)

Symbol		C	Parameter	Value		Unit
				Min	Max	
f_{OSC}	S R	—	Oscillator frequency	4	40	MHz
g_m	—	P	Transconductance	4	20	mA/V
V_{OSC}	—	T	Oscillation amplitude on XTAL pin	1	—	V
t_{OSCSU}	—	T	Start-up time[1,2]	8	—	ms

1 The start-up time is dependent upon crystal characteristics, board leakage, etc., high ESR and excessive capacitive loads can cause long start-up time.

2 Value captured when amplitude reaches 90% of XTAL

Table 28. Input clock characteristics

Symbol		Parameter	Value			Unit
			Min	Typ	Max	
f_{OSC}	SR	Oscillator frequency	4	—	40	MHz
f_{CLK}	SR	Frequency in bypass	—	—	64	MHz
t_{rCLK}	SR	Rise/fall time in bypass	—	—	1	ns
t_{DC}	SR	Duty cycle	47.5	50	52.5	%

3.12 FMPLL electrical characteristics

Table 29. FMPLL electrical characteristics

Symbol	C	Parameter	Conditions[1]	Value		Unit
				Min	Max	
$f_{ref\_crystal}$ f_{ref_ext}	D	PLL reference frequency range[2]	Crystal reference	4	40	MHz
f_{PLLIN}	D	Phase detector input frequency range (after pre-divider)	—	4	16	MHz
$f_{FMPLLOUT}$	D	Clock frequency range in normal mode	—	16	120	MHz
f_{FREE}	P	Free-running frequency	Measured using clock division — typically /16	20	150	MHz
t_{CYC}	D	System clock period	—	—	1 / f_{SYS}	ns
f_{LORL} f_{LORH}	D	Loss of reference frequency window[3]	Lower limit	1.6	3.7	MHz
			Upper limit	24	56	
f_{SCM}	D	Self-clocked mode frequency[4,5]	—	20	150	MHz

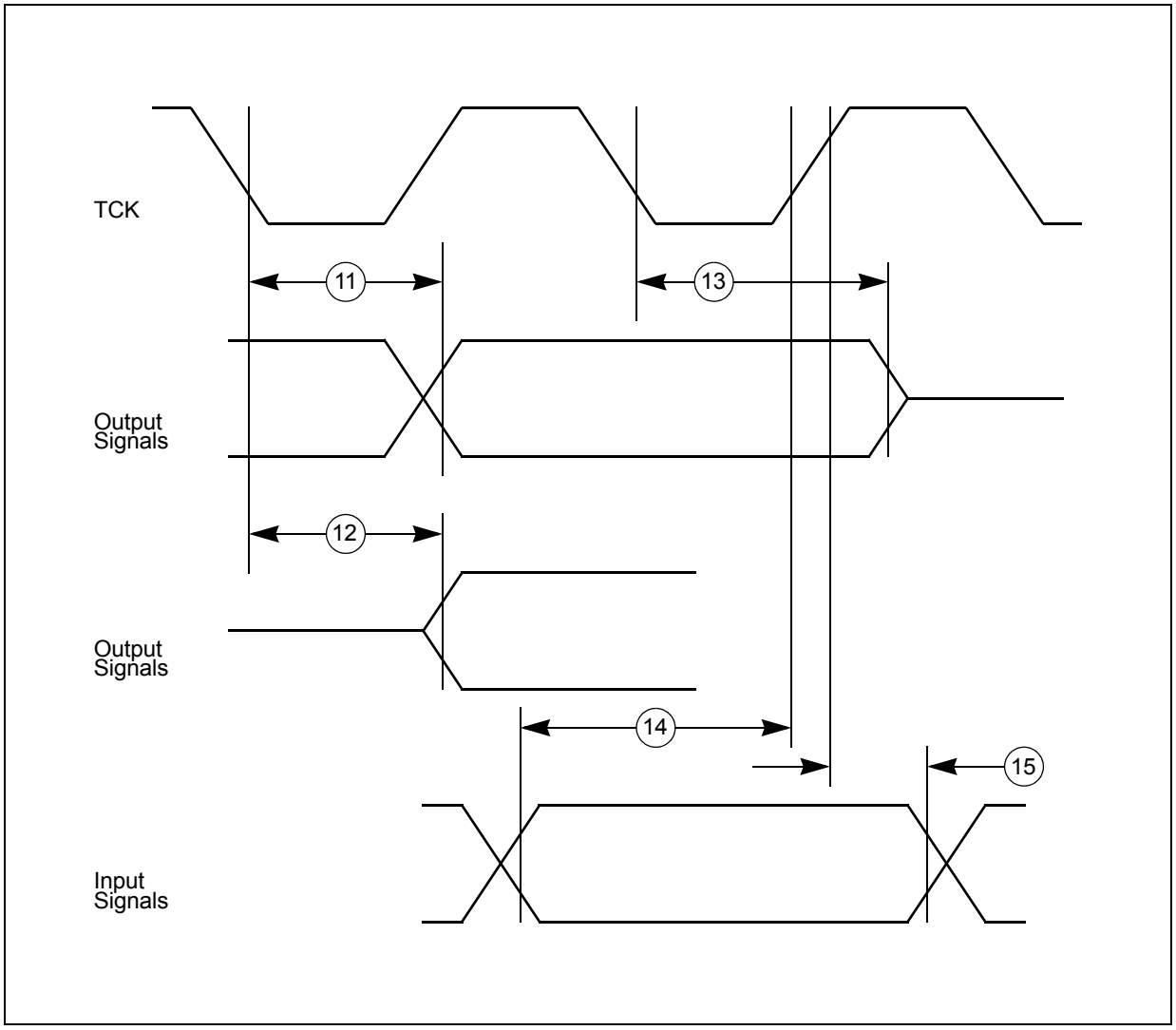


Figure 23. JTAG boundary scan timing

3.17.3 Nexus timing

Table 38. Nexus debug port timing[1]

No.	Symbol		C	Parameter	Value			Unit
					Min	Typ	Max	
1	t_{MCYC}	CC	D	MCKO cycle time	32	—	—	ns
2	t_{MDOV}	CC	D	MCKO low to MDO data valid[2]	—	—	6	ns
3	t_{MSEOV}	CC	D	MCKO low to $\overline{\text{MSEO}}$ data valid[2]	—	—	6	ns
4	t_{EVTOV}	CC	D	MCKO low to $\overline{\text{EVTO}}$ data valid[2]	—	—	6	ns
5	t_{TCYC}	CC	D	TCK cycle time	64[3]	—	—	ns

Table 38. Nexus debug port timing[1] (continued)

No.	Symbol		C	Parameter	Value			Unit
					Min	Typ	Max	
6	t_{NTDIS}	CC	D	TDI data setup time	6	—	—	ns
	t_{NTMSS}	CC	D	TMS data setup time	6	—	—	ns
7	t_{NTDIH}	CC	D	TDI data hold time	10	—	—	ns
	t_{NTMSH}	CC	D	TMS data hold time	10	—	—	ns
8	t_{TDOV}	CC	D	TCK low to TDO data valid	—	—	35	ns
9	t_{TDOI}	CC	D	TCK low to TDO data invalid	6	—	—	ns

1 All Nexus timing relative to MCKO is measured from 50% of MCKO and 50% of the respective signal.

2 MDO, $\overline{\text{MSEO}}$, and $\overline{\text{EVTO}}$ data is held valid until next MCKO low cycle.

3 Lower frequency is required to be fully compliant to standard.

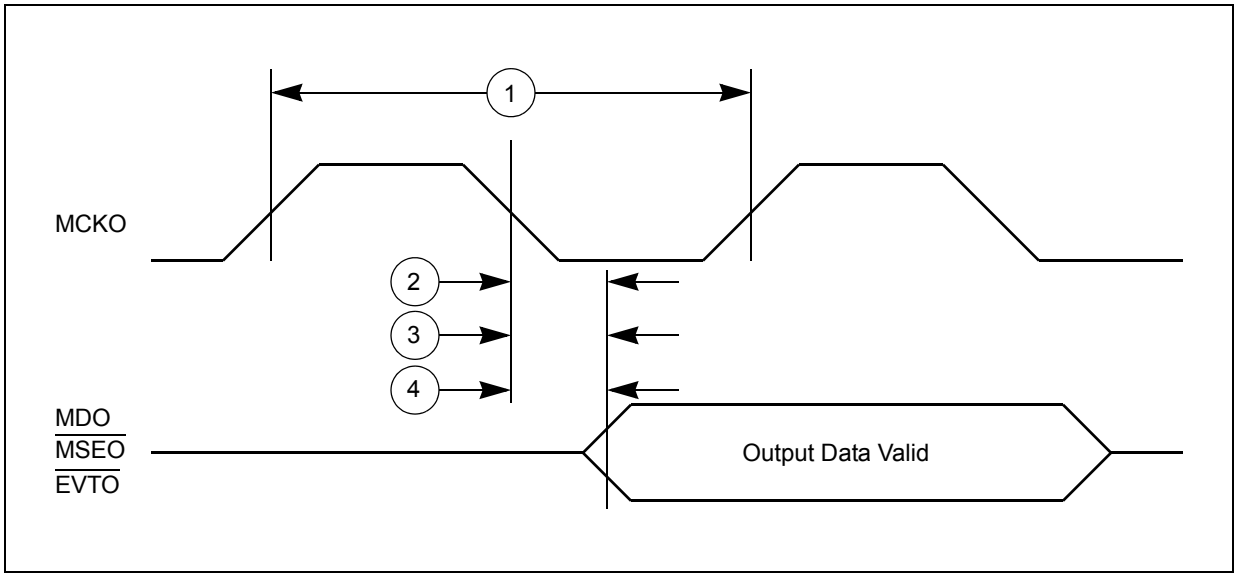


Figure 24. Nexus output timing

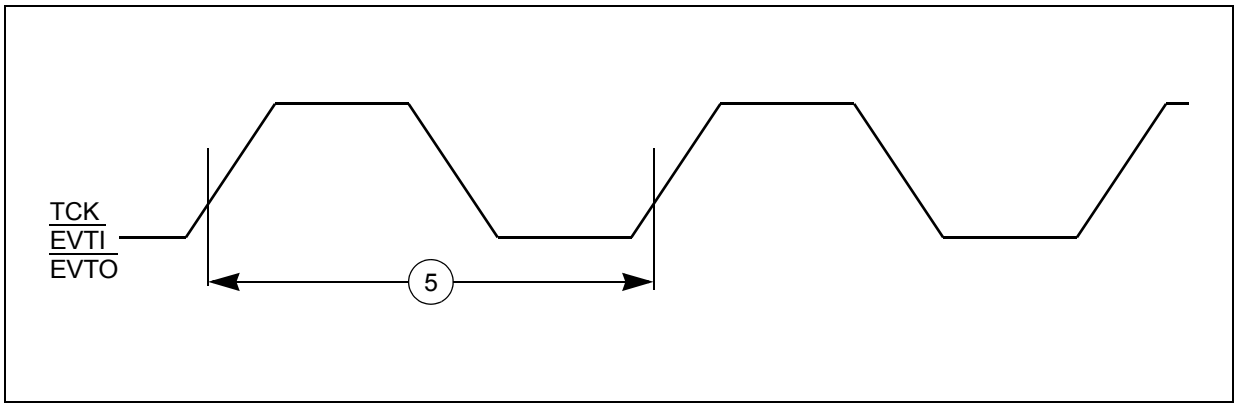


Figure 25. Nexus event trigger and test clock timings

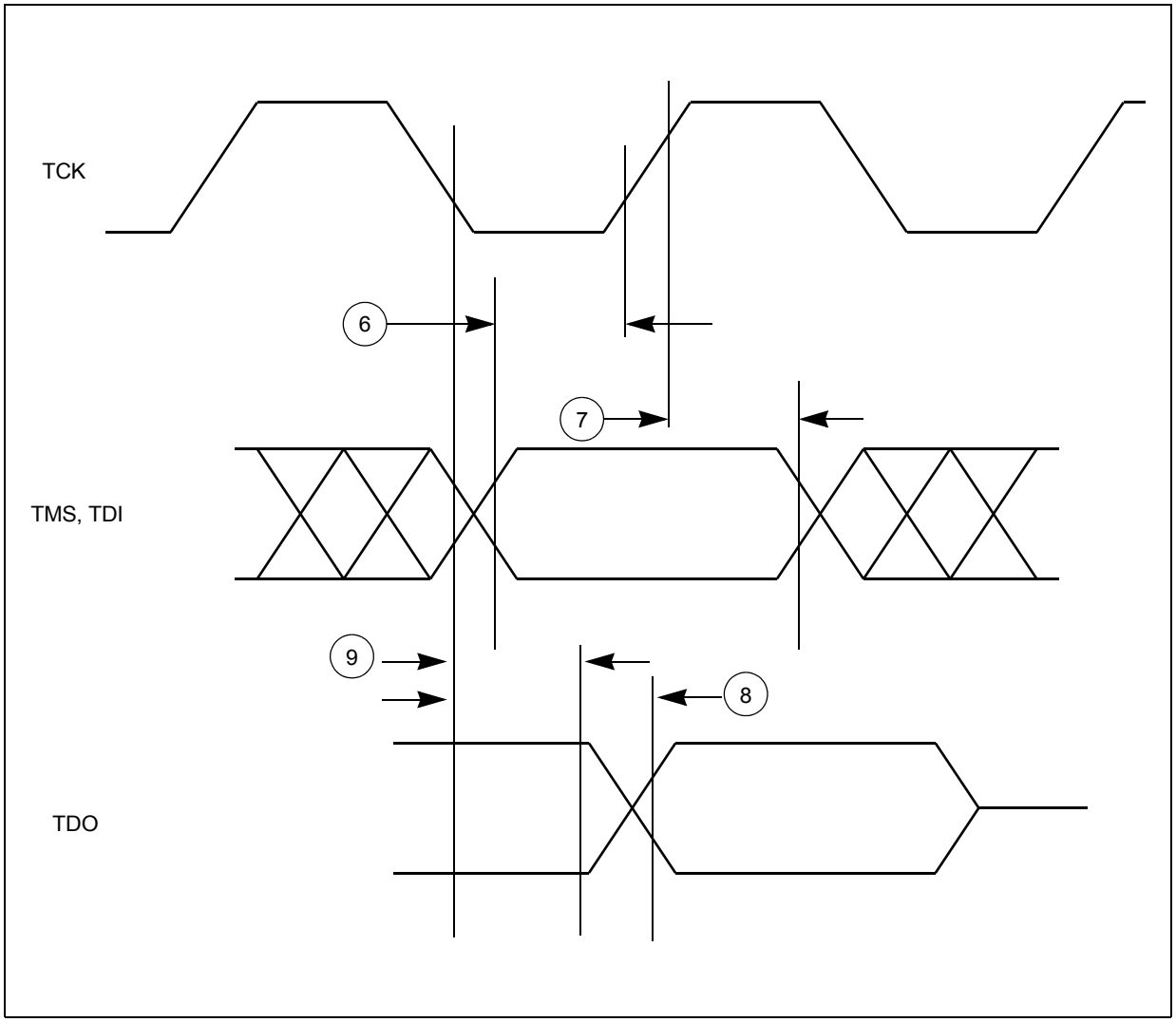


Figure 26. Nexus TDI, TMS, TDO timing

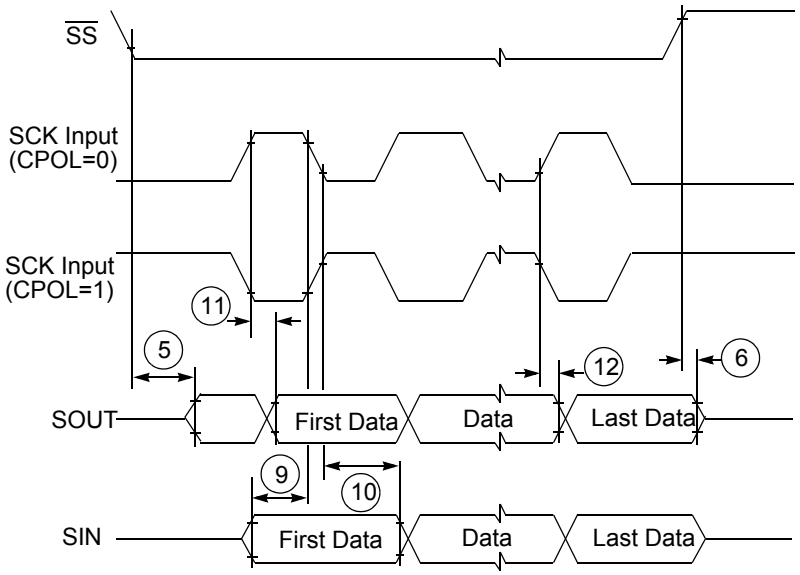
3.17.4 External interrupt timing (IRQ pin)

Table 39. External interrupt timing[1]

No.	Symbol		C	Parameter	Conditions	Value		Unit
						Min	Max	
1	t_{IPWL}	CC	D	IRQ pulse width low	—	4	—	t_{CYC}
2	t_{IPWH}	CC	D	IRQ pulse width high	—	4	—	t_{CYC}
3	t_{ICYC}	CC	D	IRQ edge to edge time[2]	—	4 + N [3]	—	t_{CYC}

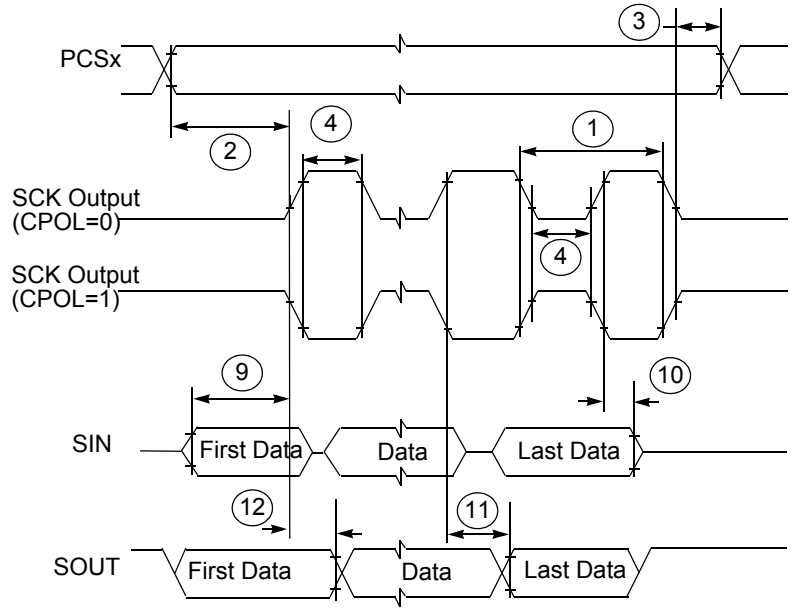
[1] IRQ timing specified at f_{SYS} = 64 MHz and $V_{DD\_HV\_IOx}$ = 3.0 V to 5.5 V, $T_A = T_L$ to T_H, and C_L = 200 pF with SRC = 0b00.

[2] Applies when IRQ pins are configured for rising edge or falling edge events, but not both.



Note: Numbers shown reference Table 40.

Figure 31. DSPI classic SPI timing – Slave, CPHA = 1



Note: Numbers shown reference Table 40.

Figure 32. DSPI modified transfer format timing – Master, CPHA = 0

4.1.2 100 LQFP mechanical outline drawing

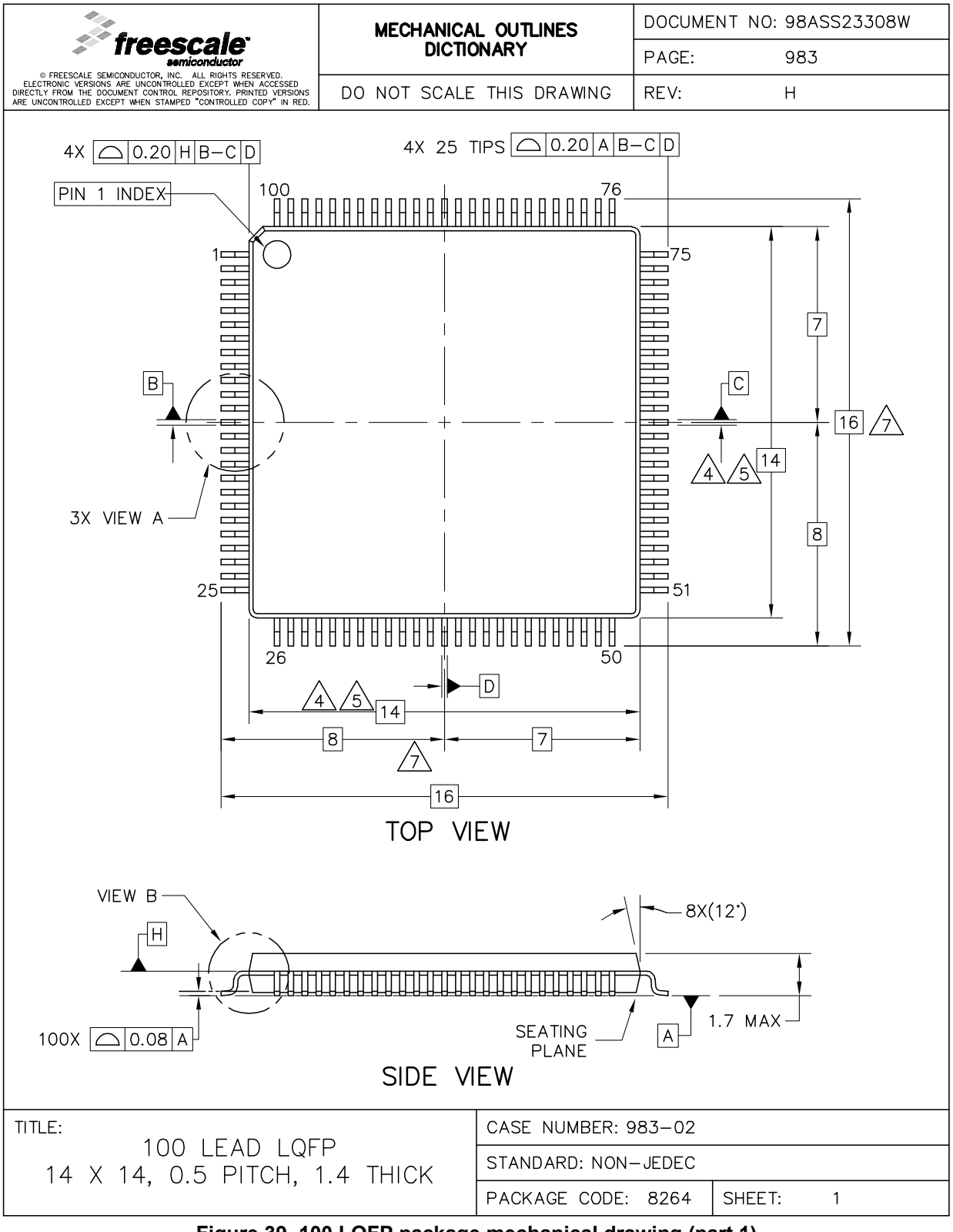


Figure 39. 100 LQFP package mechanical drawing (part 1)

Appendix A Abbreviations

Table A-1 lists abbreviations used in this document.

Table A-1. Abbreviations

Abbreviation	Meaning
CMOS	Complementary metal–oxide–semiconductor
CPHA	Clock phase
CPOL	Clock polarity
CS	Peripheral chip select
DUT	Device under test
ECC	Error code correction
EVTO	Event out
GPIO	General purpose input/output
MC	Modulus counter
MCKO	Message clock out
MCU	Microcontroller unit
MDO	Message data out
MSEO	Message start/end out
MTFE	Modified timing format enable
NPN	Negative-positive-negative
NVUSRO	Non-volatile user options register
PTF	Post trimming frequency
PWM	Pulse width modulation
RBW	Resolution bandwidth
SCK	Serial communications clock
SOUT	Serial data out
TCK	Test clock input
TDI	Test data input
TDO	Test data output
TMS	Test mode select

Table 42. Revision history (continued)

Revision	Date	Substantive changes
Rev. 8	23-May-2012	Section 1.5.4, “Flash memory: Changed “Data flash memory: 32-bit ECC” to “Data flash memory: 64-bit ECC” Figure 42 (Commercial product code structure), replaced "C = 60 MHz, 5 V" and "D = 60 MHz, 3.3 V" with respectively "C = 40 MHz, 5 V" and "D = 40 MHz, 3.3 V" Table 7 (Absolute maximum ratings), updated TV_{DD} parameter, the minimum value to 3.0 V/s and the maximum value to 0.5 V/µs Table 5 (Pin muxing), changed the description in the column "I/O direction" from "I/O" to "O" for the following port pins: A[10] with function B[0] A[11] with function A[0] A[11] with function A[2] A[12] with function A[2] A[12] with function B[2] A[13] with function B[2] C[7] with function A[1] C[10] with function A[3] C[15] with function A[1] D[0] with function B[1] D[10] with function A[0] D[11] with function B[0] D[13] with function A[1] D[14] with function B[1] Updated Section 3.8.1, “Voltage regulator electrical characteristics Added Table 25 (I/O consumption) Section 3.10, DC electrical characteristics: deleted references to “oscillator margin” deleted subsection “NVUSRO[OSCILLATOR_MARGIN] field description” Table 19 (DC electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0)), added IPU row for $\overline{\text{RESET}}$ pin Table 21 (DC electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1)), added IPU row for $\overline{\text{RESET}}$ pin Table 31 (ADC conversion characteristics), added V_{INAN} entry Removed “Order codes” table

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